


<b>Search Notes</b>  	<b>Application/Control No.</b>  10712341	<b>Applicant(s)/Patent Under Reexamination</b>  IWASAKI ET AL.
	<b>Examiner</b>  Tekle, Daniel	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	100, 113, 125	06/09/07	D.T.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST SEARCH DATA BASE (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM TDB)	06/09/07	D.T.
COMBINED CITATION	06/09/07	D.T.
SEARCH QUERY ATTACHED	06/09/07	D.T.
INVENTOR SEARCH	06/09/07	D.T.
SEARCH UPDATED	01/21/08	D.T.
SEARCH UPDATED AND SEARCH QUERY ATTACHED	06/19/08	D.T.
SEARCH UPDATED	03/28/09	D.T.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--